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**LIST OF PRIOR ART  
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Applicant  
Wadgi W. Abadeer, et al.

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**U.S. PATENT DOCUMENTS**

EXAMINER INITIAL*		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE (if appropriate)
VN	AA	5,945,834	8/31/99	Nakata, et al.			
	AB	5,898,629	4/27/99	Beffa, et al.			
	AC	5,831,445	11/3/98	Atkins, et al.			
	AD	5,661,408	8/26/97	Kamieniecki, et al.			
	AE	5,625,297	4/29/97	Arnaudov, et al.			
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	AS	5,399,101	3/21/95	Campbell, et al.			
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**OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)**

VN		"WAFFER LEVEL TEST AND BURN IN", IBM Technical Disclosure Bulletin, January 1992, pp. 401-404;
VN		"MULTI-LAYER CERAMIC SPACE TRANSFORMER FOR WAFER LEVEL STRESS", IBM Technical Disclosure Bulletin, April 1999, pp. 385 - 386;
VN		"WAFFER BURN-IN ISOLATION CIRCUIT", IBM Technical Disclosure Bulletin, November 1989, pp. 442-443

EXAMINER *Wadgi W. Abadeer* DATE CONSIDERED 10/14/06

\* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.